

# Eli Lusky

## List of Publications by Year in descending order

Source: <https://exaly.com/author-pdf/11790495/publications.pdf>

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#	ARTICLE	IF	CITATIONS
1	Spatial characterization of localized charge trapping and charge redistribution in the NROM device. Solid-State Electronics, 2004, 48, 1489-1495.	1.4	28
2	Subthreshold slope degradation model for localized-charge-trapping based non-volatile memory devices. Solid-State Electronics, 2003, 47, 937-941.	1.4	27
3	Lateral charge transport in the nitride layer of the NROM non-volatile memory device. Microelectron Engineering, 2004, 72, 426-433.	2.4	25
4	Electron Discharge Model of Locally-Trapped Charge in Oxide-Nitride-Oxide (ONO) Gates for NROM TM Non-Volatile Semiconductor Memory Devices. , 2001, , .		2